**TAI-TECH** KBM01-190600196

## **High Current Ferrite Chip Bead(Lead Free)**

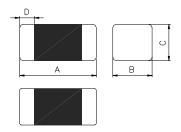
HCB1606ZF-260T60

Certificate

### 1.Features

- 1. Monolithic inorganic material construction.
- 2. Closed magnetic circuit avoids crosstalk.
- 3. Suitable for reflow soldering.
- 4. Shapes and dimensions follow E.I.A. spec.
- 5. Available in various sizes.
- 6. Excellent solder ability and heat resistance.
- 7. High reliability.
- 8.100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 9. Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 10. Operating Temperature: -55~+125° (Including self-temperature rise)

### 2.Dimensions



Chip Size							
Α	1.60±0.15						
В	0.80±0.15						
С	0.60±0.15						
D	0.30±0.20						

Units: mm

### 3.Part Numbering



A: Series

B: Dimension

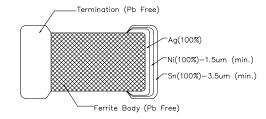
C: Material

D: Impedance

Lead Free Material **260=26**Ω

E: Packaging T=Taping and Reel, B=Bulk(Bags)

F: Rated Current 60=6000mA

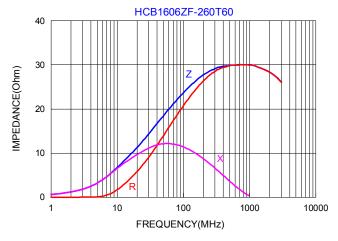


### 4. Specification

Tai-Tech Part Number	Impedance ( $\Omega$ )	Test Frequency (Hz)	DC Resistance $(\Omega)$ max.	Rated Current (mA) max.
HCB1606ZF-260T60	26±25%	60mV/100M	0.01	6000

- Rated current: based on temperature rise test
- In compliance with EIA 595

#### Impedance-Frequency Characteristics



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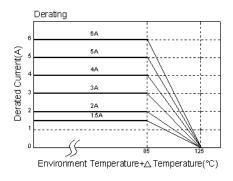
### 5. Reliability and Test Condition

Item				Te	st Cond	dition				
Series No.	FCB	FCB FCM HCB GHB FCA								
Operating Temperature		(Includ	-55~+125°C ing self-tempera	ature rise)						
Transportation Storage Temperature			-55~+125℃ (on board)			For long			ons, please	see the
Impedance (Z)	Pefer to stand	dard electrical ch	paractoristics list			Agilent42 Agilent E Agilent42 Agilent16	4991 287			
DC Resistance	_ INCICI IO SIAIN	Agilent 4								
Rated Current					DC Powe Over Rat some risk	ed Curr		ements, the	re will be	
Temperature Rise Test		1A ΔT 20℃Max = 1A ΔT 40℃Max			2. Tempe therm	erature r ometer.		by digital su		
Life test		within±15%of initi				times.( IF Reflow P Tempera Applied of Duration: Measure for 24±2	PC/JEDI rofiles) ture: 12 current: : 1000± d at ro hrs.	EC J-STD  5±2°C  rated curr  12hrs.  om tempe	erature afte	sification
Load Humidity	Inductance: within±10%of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value.						Preconditioning: Run through IR reflow for times. (IPC/JEDEC J-STD-020D Classificat Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2°C. Duration: 1000hrs Min. with 100% rat current. Measured at room temperature after place for 24±2 hrs.			
Thermal shock	Inductance: v Q : Shall not	within±15%of initi vithin±10%of initi exceed the spec	al value. cification value.	ot exceed the spe	ecification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: -55±2°C 30±5 min. Step2: 25±2°C ≤0.5min Step3: +125±2°C 30±5min. Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs.				
Vibration	Inductance : Q : Shall not	within±15% of in within±10% of in exceed the spec	itial value cification value.	ot exceed the spe	ecification value	times.( IF Reflow P Oscillatio minutes Equipme Total Am	PC/JEDI Profiles) on Frequent: Vil plitude: Time: 1:	EC J-STD uency: 10 bration che 1.52mm±1 2 hours(20		sification
Appearance: No damage. Impedance: within±10% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification valu						Shall be mounted on a FR4 substrate of the following dimensions: >=0805inch(2012mm):40x100x1.2mm <0805inch(2012mm):40x100x0.8mm Bending depth: >=0805inch(2012mm):1.2mm <0805inch(2012mm):0.8mm Duration of 10 sec for a min.				
						Test cor	ndition			
Shock	Impedance:	: No damage. within±10% of in within±10% of in				Туре	Peak Value (g's)	Normal duration (D) (ms)	Wave form	Velocity change (Vi)ft/sec
		exceed the spec ±15% of initial va		ot exceed the spe	ecification value	SMD	50	11	Half-sine	11.3
	1.50 · WILLIII	0,0 01 1111101 10	a.ao ana onan m	or overed the she	Julion Value	Lead	50	11	Half-sine	11.3
Solderability	More than 959	% of the terminal	electrode shoul	ld be covered with	n solder.	Solder te	Sn96.5% mperati ead free omplete	5-Ag3%-Cure: 245±5 e: Rosin. 9 ly cover th	5℃	on.

Item	Performance	Test Condition
		Number of heat cycles: 1
Resistance to Soldering	Appearance : No damage. Impedance : within±15% of initial value	Temperature (s) Time Temperature ramp/immersion and emersion rate
Heat	Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value.	260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s
		Depth: completely cover the termination
Terminal strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) Component mounted on a PCB apply a force >0805inch(2012mm):1kg <=0805inch(2012mm):0.5kg to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to shock the component being tested.

### \*\*Derating Curve

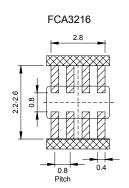
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over  $85^{\circ}\mathrm{C}$ , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



### 6. Soldering and Mounting

#### 6-1. Recommended PC Board Pattern

		Land Patterns For Reflow Soldering						
Series	Туре	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	F(mm)	G(mm)
	0603	0.6±0.03	0.30±0.03	0.30±0.03	0.15±0.05	0.35	0.30	0.40
FCB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	0.50	0.40	0.60
FCM	<mark>1606</mark>	1.6±0.15	0.80±0.15	0.60±0.15	0.30±0.20	<mark>0.80</mark>	<mark>0.85</mark>	<mark>0.95</mark>
HCB	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	0.80	0.85	0.95
GHB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	1.05	1.00	1.45
FCI	2012	2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30		1.00	1.45
FHI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	1.05	2.20	1.80
FCH	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	1.05	2.20	2.70
HCI	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	1.05	3.30	1.80
	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	1.05	3.30	3.40



Land
Solder Resist



PC board should be designed so that products can prevent damage from mechanical stress when warping the board.

### 6-2. Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

Note.

If wave soldering is used ,there will be some risk.

Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

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#### 6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. (Refered to J-STD-020C)

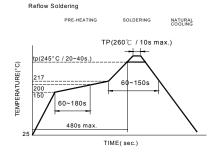
#### 6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. If a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.

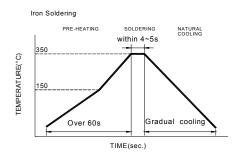
- Preheat circuit and products to 150°C
  350°C tip temperature (max)
- Never contact the ceramic with the iron tip

• 1.0mm tip diameter (max)

- Use a 20 watt soldering iron with tip diameter of 1.0mm
- Limit soldering time to 4~5sec.



Reflow times: 3 times max Fig.1



Iron Soldering times: 1 times max

#### 6-2.3 Solder Volume:

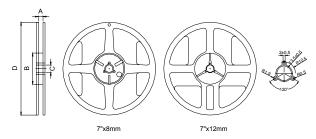
Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height



### 7. Packaging Information

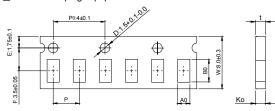
#### 7-1. Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)	
7"x8mm	9.0±0.5	<mark>60±2</mark>	<mark>13.5±0.5</mark>	<mark>178±2</mark>	
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2	

#### 7-2.1 Tape Dimension / 8mm

### ■Material of taping is paper



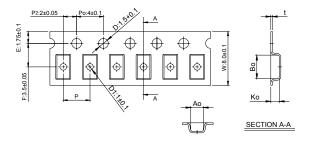
	P:2±0.1 P:04±0.1 Q165Q1,Q05	
_	P2:2±0.1 P0:4±0.1	-  t  -
E:1.75±0.1		Н
ā		
-		
F:3.5±0.1		
щ	P A0	Ko _

Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	
060303	0.70±0.06	0.40±0.06	0.45max	2.0±0.05	0.45max	
100505	1.12±0.03	0.62±0.03	0.60±0.03	2.0±0.05	0.60±0.03	

	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
	<mark>160806</mark>	<mark>1.78±0.03</mark>	<mark>0.97±0.03</mark>	0.75±0.03	4.0±0.10	0.78max
	160808	1.80±0.05	0.96+0.05/-0.03	0.95±0.05	4.0±0.10	0.95±0.05
_	201209	2.10±0.05	1.30±0.05	0.95±0.05	4.0±0.10	0.95±0.05

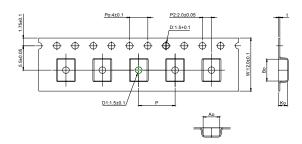
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#### ■Material of taping is plastic



Size	Bo(mm) Ao(mm		Ko(mm)	P(mm)	t(mm)	D1(mm)
201212	2.10±0.10	1.28±0.10	1.28±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321611	3.35±0.10	1.75±0.10	1.25±0.10	4.0±0.10	0.23±0.05	1.0±0.10
322513	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321609	3.40±0.10	1.77±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10

#### 7-2.2 Tape Dimension / 12mm

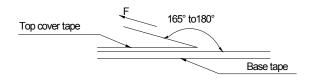


Size	Bo(mm)	Bo(mm) Ao(mm)		P(mm)	t(mm)	D1(mm)
451616	4.70±0.10	1.75±0.10	1.75±0.10	4.0±0.10	0.24±0.05	1.5±0.10
453215	4.70±0.10	3.45±0.10	1.60±0.10	8.0±0.10	0.24±0.05	1.5±0.10

#### 7-3. Packaging Quantity

Chip Size	453215	451616	322513	321611	321609	201212	201209	160808	<mark>160806</mark>	100505	060303
Chip / Reel	1000	2000	2500	3000	3000	2000	4000	4000	<mark>4000</mark>	10000	15000
Inner box	4000	8000	12500	15000	15000	10000	20000	20000	20000	50000	75000
Middle box	20000	40000	62500	75000	75000	50000	100000	100000	100000	250000	375000
Carton	40000	80000	125000	150000	150000	100000	200000	200000	200000	500000	750000

#### 7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed	
(℃)	(%)	(hPa)	mm/min	
5~35	45~85	860~1060	300	

### **Application Notice**

Storage Conditions(component level)

To maintain the solder ability of terminal electrodes:

- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40  $^{\circ}\mathrm{C}$  and 60% RH.
- 3. Recommended products should be used within 12 months from the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.





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# **Test Report**

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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(中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P. R., CHINA)

### 以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

樣品名稱(Sample Description)

: FERRITE CHIP BEAD > FERRITE CHIP INDUCTOR > ARRAY > MCF > MCM > YMV SERIES

樣品型號(Style/Item No.)

FERRITE CHIP BEAD · FERRITE CHIP INDUCTOR · ARRAY · MCF · MCM · YMV SERIES

收件日期(Sample Receiving Date)

2018/12/04

測試期間(Testing Period)

2018/12/04 to 2018/12/11

測試結果(Test Results) : 請參閱下一頁 (Please refer to following pages).



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### 測試結果(Test Results)

測試部位(PART NAME)No.1

: 整體混測 (MIXED ALL PARTS)

测試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鍋 / Cadmium (Cd)	mg/kg	參考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With	2	n. d.
鉛 / Lead (Pb)	mg/kg	reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n.d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321-4 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-4 (2013) and performed by ICP-AES.	2	n.d.
六價絡 / Hexavalent Chromium Cr(VI)	mg/kg	参考IEC 62321-7-2 (2017),以UV-VIS 檢測. / With reference to IEC 62321-7-2 (2017) and performed by UV-VIS.	8	n. d.
六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified ( $\alpha$ - HBCDD, $\beta$ - HBCDD, $\gamma$ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	mg/kg	參考IEC 62321 (2008),以氣相層析儀/ /質譜儀檢測. / With reference to IEC 62321 (2008). Analysis was performed by GC/MS.	5	n. d.

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**Test Report** 

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測試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
多湊聯苯總和 / Sum of PBBs	mg/kg			n. d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n. d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n, d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.
七溴聯苯 / Heptabromobiphenyl	mg/kg	]	5	n. d.
へ溴聯苯 / Octabromobiphenyl	mg/kg	]	5	n. d.
九溴聯苯 / Nonabromobiphenyl	mg/kg	多考IEC 62321-6 (2015),以氣相層析	5	n. d.
十溴聯苯 / Decabromobiphenyl	mg/kg	儀/質譜儀檢測. / With reference to	5	n. d.
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	IEC 62321-6 (2015) and performed		n, d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	by GC/MS.	5	n. d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n. d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg	]	5	n. d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg	]	5	n. d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n. d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg	_	5	n.d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg	] [	5	n. d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg	] [	5	n. d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg	] [	5	n. d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg	] [	5	n. d.

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	mg/kg		50	n. d.
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n. d.
鄉苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.
鄰苯二甲酸二異丁酯 / DIBP (Di- isobutyl phthalate) (CAS No.: 84-69- 5)	mg/kg	参考IEC 62321-8 (2017),以氣相層析	50	n. d.
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761- 40-0; 68515-49-1)	mg/kg	儀/質譜儀檢測. / With reference to IEC 62321-8 (2017). Analysis was performed by GC/MS.	50	n. d.
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553- 12-0; 68515-48-0)	mg/kg		50	n. d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n- octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.
鄰苯二甲酸二正己酯 / DNHP (Di-n-hexyl phthalate) (CAS No.: 84-75-3)	mg/kg		50	n. d.
鄰苯二甲酸二戊酯 / DNPP (Di-n-pentyl phthalate) (CAS No.: 131-18-0)	mg/kg		50	n. d.

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鹵素 / Halogen				
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n. d.
鹵素(氣)/ Halogen-Chlorine (C1) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582 (2016),以離子層析 儀分析. / With reference to BS EN	50	n. d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	14582 (2016). Analysis was performed by IC.	50	n. d.
鹵素 (碘) / Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg		50	n, d.
全氟辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	参考US EPA 3550C (2007),以液相層 析儀/質譜儀檢測. / With reference to US EPA 3550C (2007). Analysis	10	n. d.
全氟辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	was performed by LC/MS.	10	n. d.
聚氯乙烯 / PVC	**	以紅外光譜分析及焰色法檢測. / Analysis was performed by FTIR and FLAME Test.	-	Negative
銻 / Antimony (Sb)	mg/kg	参考US EPA 3052 (1996),以感應耦合	2	n. d.
砷 / Arsenic (As)	mg/kg	電漿原子發射光譜儀檢測. / With reference to US EPA 3052 (1996). Analysis was performed by ICP-AES.	2	n. d.
鈹 / Beryllium (Be)	mg/kg		2	n. d.

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### 備註(Note):

- 1. mg/kg = ppm : 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限值)
- 4. "-" = Not Regulated (無規格值)
- 5. \*\*= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗層材料中不得超過 $1\mu g/m^2$ 。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above  $1\mu g/m^2$ .)

8. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

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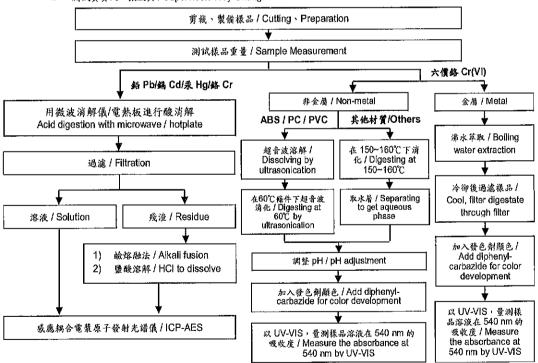
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### 重金屬流程圖 / Analytical flow chart of Heavy Metal

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外)

These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr8+ test method excluded)

- 測試人員:陳恩臻 / Technician: Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang



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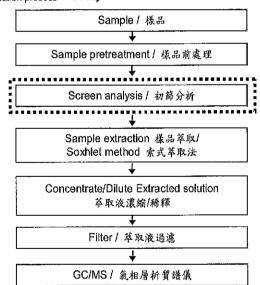
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#### 多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

■ 測試人員:涂雅苓 / Technician: Yaling Tu

■ 測試負責人:張啟興 / Supervisor: Troy Chang



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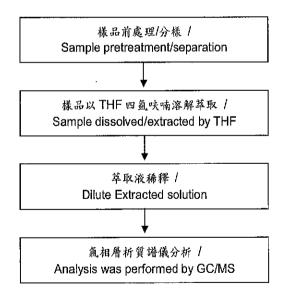
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### 可塑劑分析流程圖 / Analytical flow chart - Phthalate

■ 測試人員:涂雅苓 / Technician: Yaling Tu

■ 測試負責人:張啟興 / Supervisor: Troy Chang

【测試方法/Test method: IEC 62321-8】



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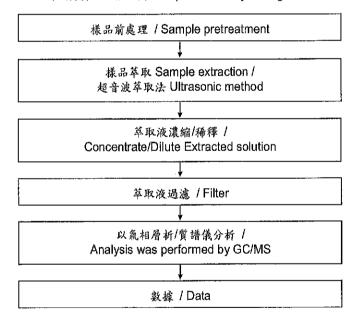
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### 六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

■ 測試人員:涂雅苓 / Technician: Yaling Tu

■ 測試負責人:張啟興 / Supervisor: Troy Chang



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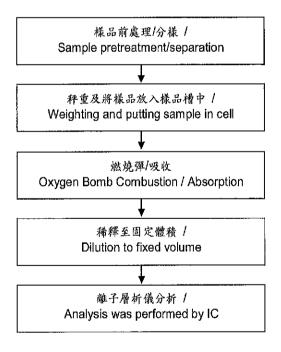
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### 鹵素分析流程圖 / Analytical flow chart - Halogen

■ 測試人員:陳恩臻 / Technician: Rita Chen

■ 測試負責人:張啟興 / Supervisor: Troy Chang



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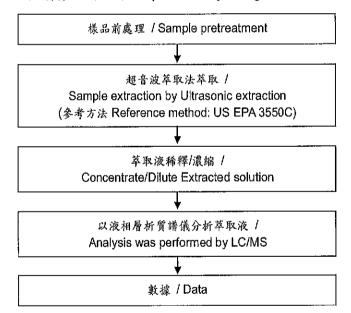
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### 全氟辛酸/全氟辛烷磺酸分析流程圖 / Analytical flow chart - PFOA/PFOS

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang





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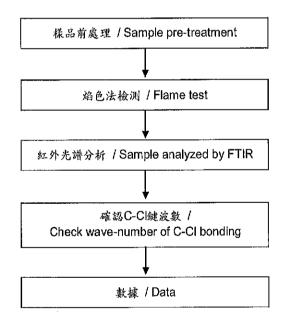
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### 聚氯乙烯物質判定分析流程圖 / Analysis flow chart - PVC

測試人員:涂雅苓 / Technician: Yaling Tu

測試負責人:張啟與 / Supervisor: Troy Chang



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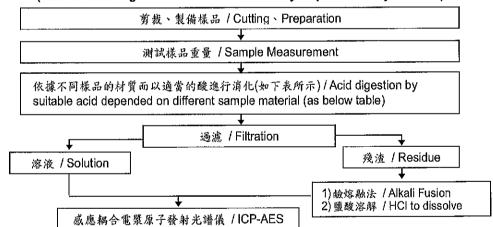
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根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

- 測試人員: 陳恩臻 / Technician: Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang

### 元素以 ICP-AES 分析的消化流程圖 (Flow Chart of digestion for the elements analysis performed by ICP-AES)



鲷,銅,鋁,焊錫 / Steel, copper, aluminum, solder	王水,硝酸,鹽酸,氫氟酸,雙氧水 /
	Aqua regia, HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub>
玻璃 / Glass	硝酸,氫氟酸 / HNO3/HF
金,鉑,鲃,陶瓷 / Gold, platinum, palladium, ceramic	王水 / Aqua regia
銀 / Silver	硝酸 / HNO <sub>3</sub>
塑膠 / Plastic	硫酸,雙氧水,硝酸,鹽酸 / H2SO4, H2O2, HNO3, HCI
其他 / Others	加入適當的試劑至完全溶解 / Added appropriate reagent to total digestion

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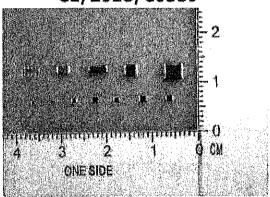
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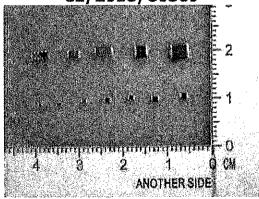
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\* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. \* (The tested sample / part is marked by an arrow if it's shown on the photo.)

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